

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/825,453	<b>Applicant(s)/Patent under Reexamination</b> SIMON ET AL.
<b>Examiner</b> Thu V. Huynh	<b>Art Unit</b> 2178	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner